

Notice of References Cited

Application/Control No.

10/500,748

Applicant(s)/Patent Under
Reexamination
LEE ET AL.

Examiner

WU-CHENG Winston SHEN

Art Unit

1632

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0120400	06-2005	Day et al.	800/017
*	B	US-5,576,201	11-1996	Mason et al.	435/456
*	C	US-2003/0092070	05-2003	Zhao et al.	435/7.2
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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